Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/817,510	DEPUE ET AL.
Examiner	**Art Unit**
José V. Chen	3637

SEARCHED

Class	Subclass	Date	Examiner
106	44 45 162	1/6/06	JC
	42		
	48		
224	400	5/3/06	JC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Fax & Back Cover Prior Art	1/18/06	JC
	5/3/06	JC
	6/12/06	JC
	11/14/06	JC